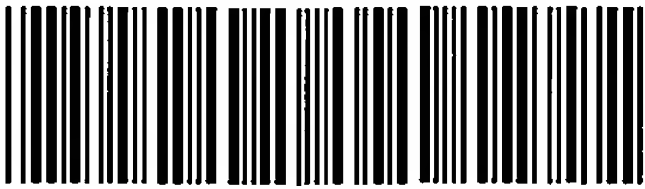


Search Notes



Application/Control No.

10/632,641

Examiner

Edward Wojciechowicz

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	347, 348, 365, 401, 406, 411	4-1-05	EW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	347, 348, 365, 401, 406, 411	4-1-05	EW

SEARCH NOTES
(INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST (multiple gates) 257/ 347, 348, 365, 401, 406, 411	4-1-05	EW